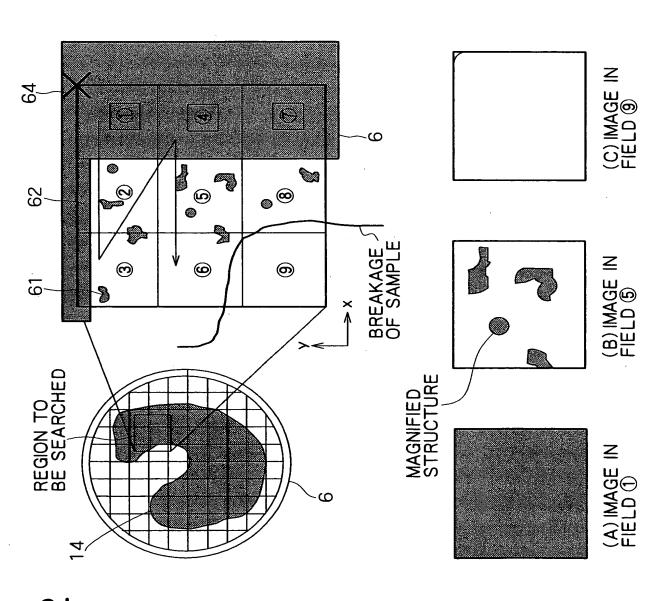


FIG.1







F1G.2



F1G.3B

FIG.3A

Z ≥ 61

65 61 Σ



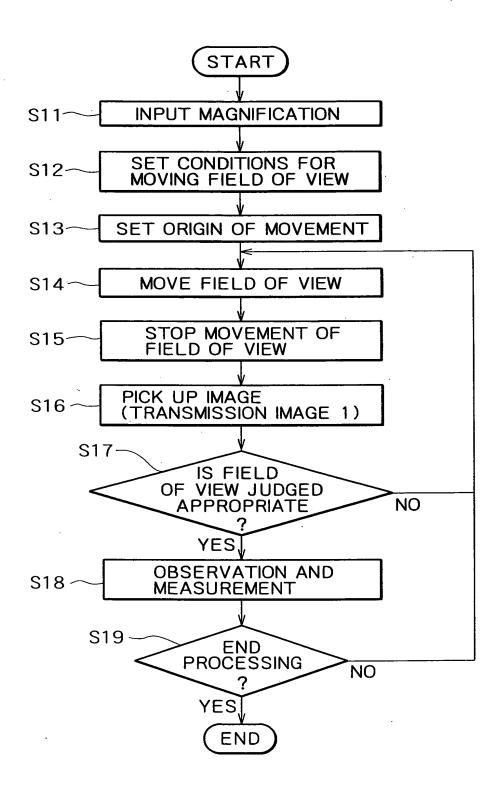




FIG.5A

FIG.5B

-72

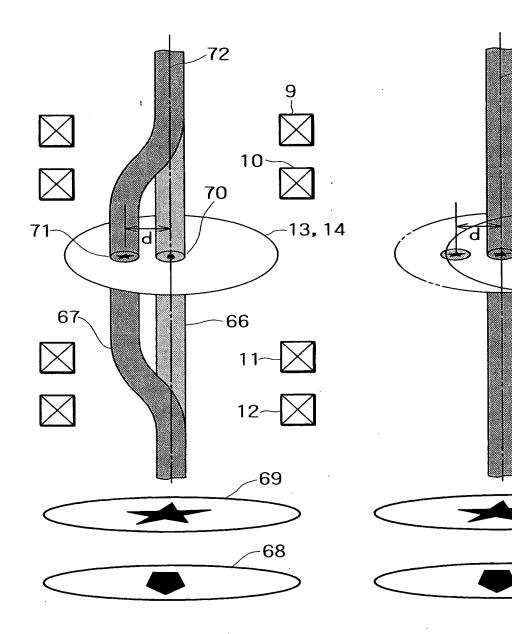
71

70

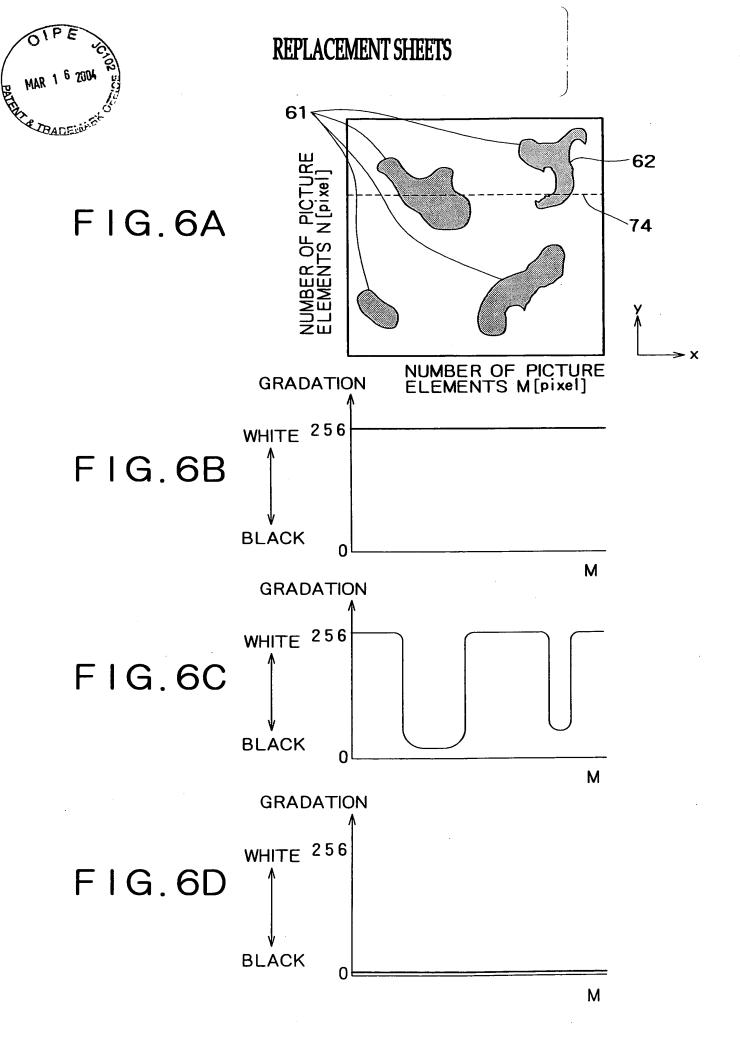
13, 14

69

68

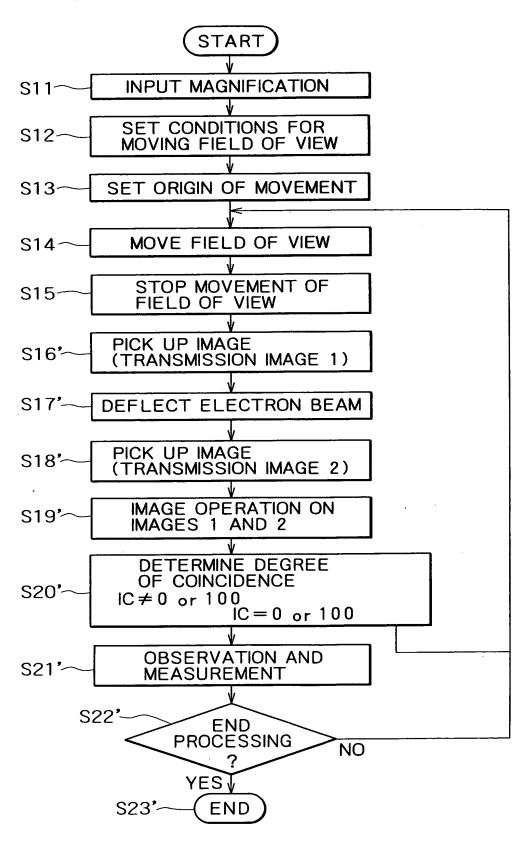


ELECTROMAGNETIC MOVEMENT OF FIELD OF VIEW USING ELECTRON BEAM DEFLECTING COIL MECHANICAL MOVEMENT OF FIELD OF VIEW USING SAMPLE STAGE DRIVER



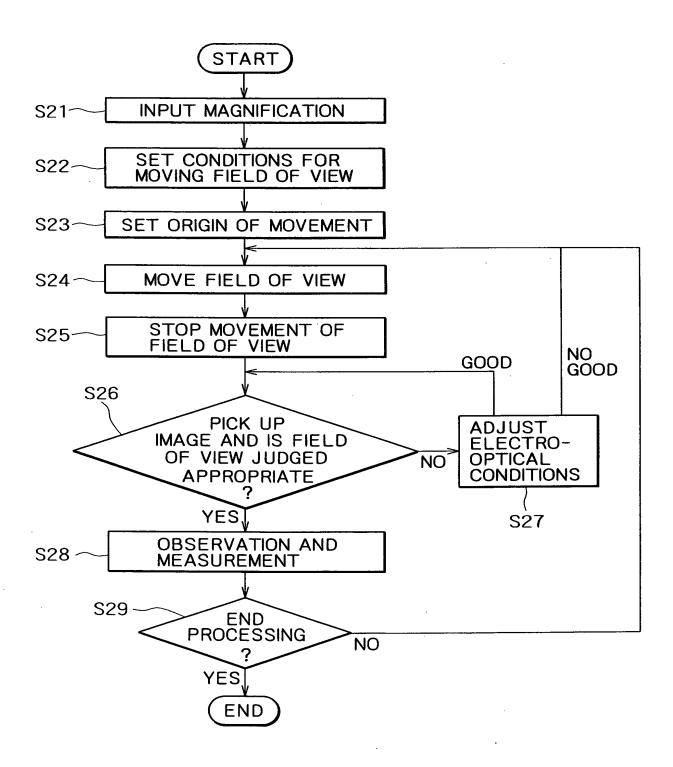
MAR 1 6 2004 BERNARIAN FOR THE PROPERTY OF THE

REPLACEMENT SHEETS

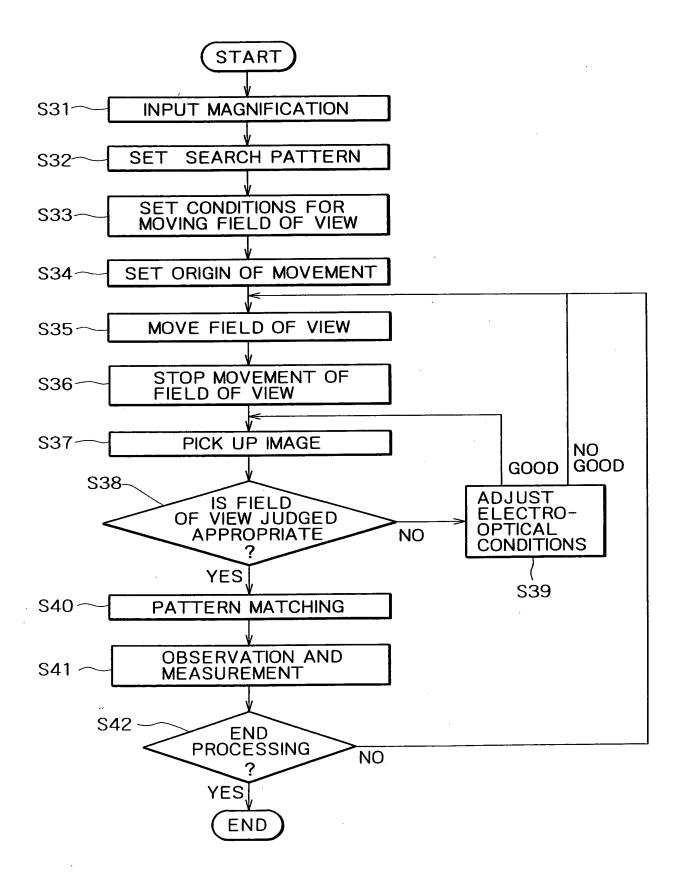


MAR 1 6 2004 PER PRACE SAME TO SAME TO

REPLACEMENT SHEETS









F1G.10B

SEARCH SAMPLE (MARKING)

PICKED-UP FIELD OF VIEW NUMBER OF SEARCH SAMPLES=2

SEARCH TARGET PATTERN

F1G. 10A

REPLACEMENT SHEETS RATE DE ALESTA FIG. 11 **START** INPUT MAGNIFICATION S51-S52-SEARCH PATTERN SET SET CONDITIONS FOR S53~ MOVING FIELD OF VIEW S54-SET ORIGIN OF MOVEMENT MOVE FIELD OF VIEW S55⁻ STOP MOVEMENT OF S56⁻ FIELD OF VIEW PICK UP IMAGE S57~ (TRANSMISSION IMAGE 1) S58-DEFLECT ELECTRON BEAM PICK UP IMAGE S59⁻ (TRANSMISSION IMAGE 2) IMAGE OPERATION ON S60⁻ IMAGES 1 AND 2 DETERMINE DEGREE OF COINCIDENCE S61⁻ IC=100 IC < 5 IC>5 IC = 0**AUTOMATIC FOCUS** CORRECTION S 62 PATTERN MATCHING S63-**OBSERVATION AND** S64-**MEASUREMENT** S65 END PROCESSING ?_ NO YEST

END

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REPLACEMENT SHEETS

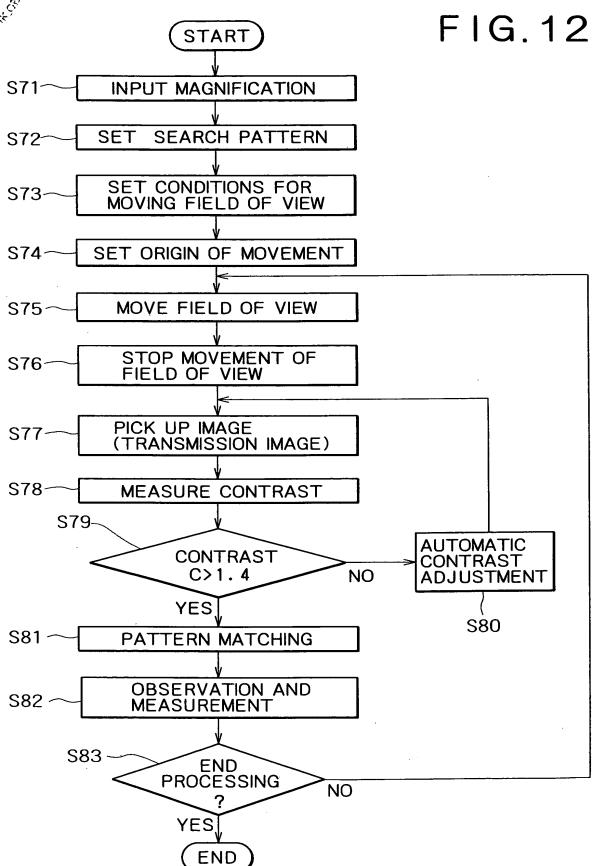
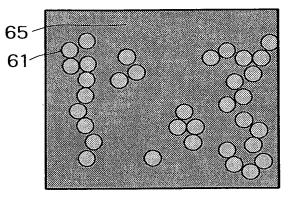




FIG. 13(1)



CONTRAST C=1.1

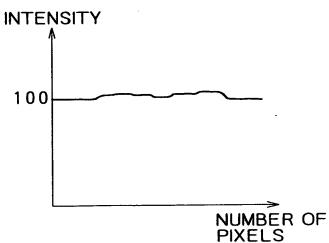
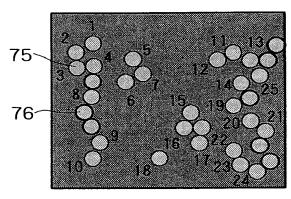


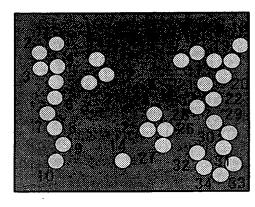
FIG. 13(2)



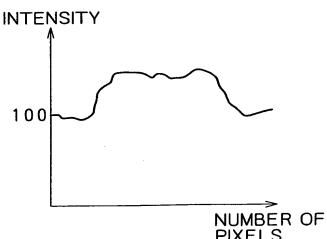
CONTRAST C=1.2

INTENSITY 100 11 10 NUMBER OF PIXELS

FIG. 13 (3)



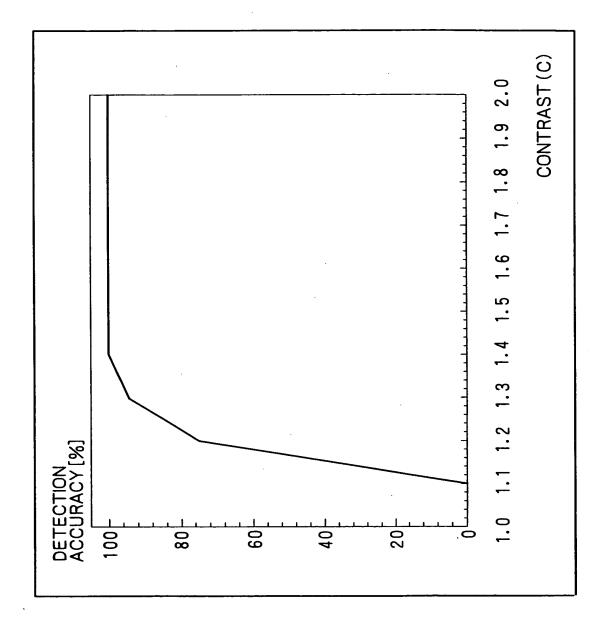
CONTRAST C=1.6



NUMBER OF PIXELS







F1G.14

MAR 1 6 2004 P.

REPLACEMENT SHEETS

